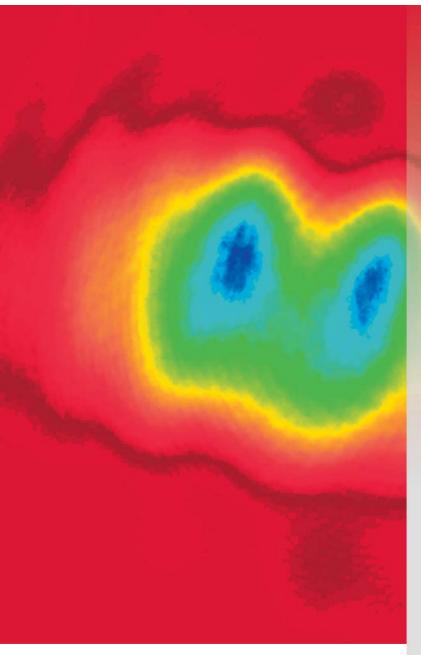
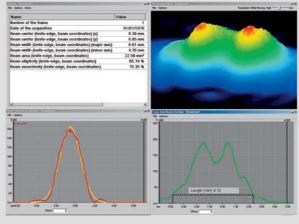


ML4500

Beam Diagnostic Systems



- Reliable quality control online
   with our ML1200 beamlux II software for
   production with PASS/FAIL output
- Improve efficiency
   with real time evaluation of beam size and
   homogeneity
- Speed up production
   online monitoring and evaluation of laser
   beam, faster set-up, faster production,
   faster throughput
- Reliable results
   with evaluations in compliance to ISO Norm
- Save on your production cost on-line results while adjusting of optical components (tuning)
- Improve productivity
  real time evaluation of laser beam profile,
  1D, 2D, 3D display
- Shorten time in quality control customize evaluation, instant display in table format, Pass/Fail, all raw data preserved if needed for evaluation.



Everything can be improved • We give you a tool to be faster

The typical application for ML4500 is general beam profiling. It consists of a ML3743 camera and ML1200 beamlux software.

With our comprehensive accessories almost all cw or quasi-CW lasers can be analysed.

It is an ideal tool for online adjustment and improvement of your laser and optical set up.

Due to its high dynamic range camera with long exposure time it is a perfect tool for recording caustics of laser spots for M<sup>2</sup> measurements.

# **Specifications**

Wavelength range 320 nm - 1100 nm with optional UV-converter 10 nm - 320 nm Power density cw < 1 nW/cm² - 1 mW/cm² with optional attenators 10.000 W/cm² Beam size 500 µm - 5 mm with optional extension tubes < 5 µm - 150 mm

#### camlux ML3743

culliux IIIES7 15	
CCD-Sensor	2/3"
Pixel #	1392 x 1040
Pixel size	6.45 x 6.45 µm
Array size	8.97 x 6.71 mm
Max. frame rate	14.8 fps
	60 fps with binning
Exposure time	20 µs - 1 s
Long-time exposure	up to 20 min
Binning	x2, x4, x8
S/N ratio	63 dB
Dynamic	12 bit
Full well capacity	18000 e <sup>-</sup>

CE/UL certified

#### beamlux II Software ML1200

- Automatic gain and shutter control
- Noise and background control
- Best fit to Gaussian or top hat profile
- Numerical data files of profiles
- Centroid beam wander screen and tracking
- 2D contour map and best-fit ellipse
- 3D display viewable from any angle or elevation with zoom
- Store and recall screens in single or video fashion
- Fully flexible screen format including save configuration
- Full on-line instructions and help
- Progression view (time dependent view of all important laser beam parameters, for long time measurements of your laser beam)
- Decreasing measurement errors by averaging
- ISO standard compliant

### **Evaluation results**

with Pass / Fail indication

Name	Value	Deviation
Date of the acquisition	02/27/2007	781
Beam center (second moment) (x)	3.61 mm	0.00 mm
Beam center (second moment) (y)	2.19 mm	0.00 mm
Beam width (second moment) (major axis)	2.91 mm	0.00 mm
Beam width (second moment) (minor axis)	2.59 mm	0.00 mm
Beam area (second moment)	5.911 mm²	0.0015 mm <sup>2</sup>
Beam ellipticity (second moment)	89.17 %	0.02 %
Plateau intensity (2D ROI)	1.53 Cnts/µm²	0.00 Cnts/µm²
Plateau multimodal? (2D ROI)	no	
Plateau uniformity (2D ROI)	4.90 %	0.02 %
Relative plateau uniformity (2D ROI)	5.05 %	0.02 %
Plateau edge steepness (2D ROI)	14.01 %	0.04 %
Plateau relative threshold (2D ROI)	0.00 %	0.00 %
Plateau evenness factor (threshold, 2D ROI)	26.70 %	0.01 %

## beamlux II advanced upgrade

- Laser beam synchronization
- Control of more than one camera synchronously
- Control of stepper motors
- Script support
- Remote control via TCP/IP
- Customizable software



Optische Messtechnik GmbH Bertha-von-Suttner-Straße 5 37085 Göttingen, Germany fon: +49 (0) 55 1 79 76 7 0 fax: +49 (0) 55 1 79 76 7 24 **metrolux** Optische Messtechnik GmbH Bichlmairstrasse 15 82061 Neuried - Munich, Germany

fon: +49 (0) 89 7 45 296 89 fax: +49 (0) 89 7 45 296 95 **metrolux** analytics Inc. PO Box 13282 Reno, NV 89505, USA

fon: 775 250 3379 fax: 734 370 6537